

C2012X8R1H104M125AA

TDK Item Description : C2012X8R1H104MT****



Application & Main Feature

Commercial Grade (High Temperature Application)

Series

C2012 [EIA CC0805]



Dimensions

L 2.00mm +/-0.2mm
 W 1.25mm +/-0.2mm
 T 1.25mm +/-0.2mm
 B 0.20mm Min.
 G 0.50mm Min.

Temperature Characteristic

X8R (-55 to 150 degC +/-15%)

Rated Voltage

1H (50Vdc)

Capacitance

100nF

Capacitance Tolerance

M (+/-20%)

Dissipation Factor

3% Max.

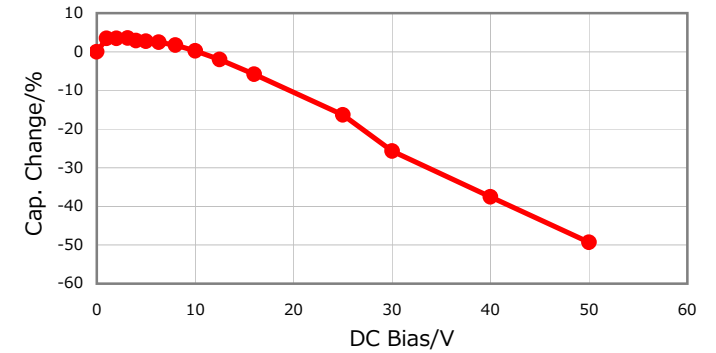
Insulation Resistance

5Gohm Min.

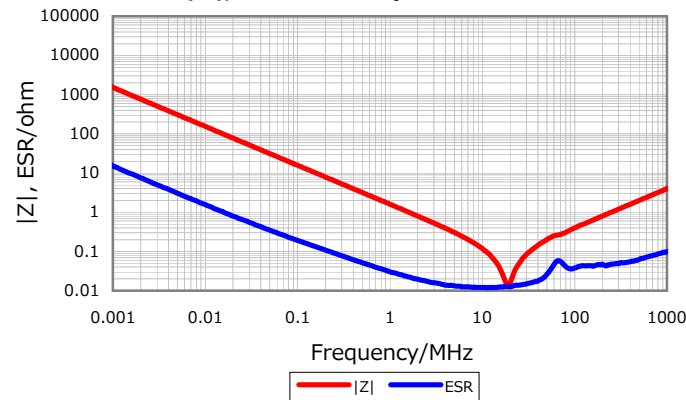
AEC-Q200

Not Applicable

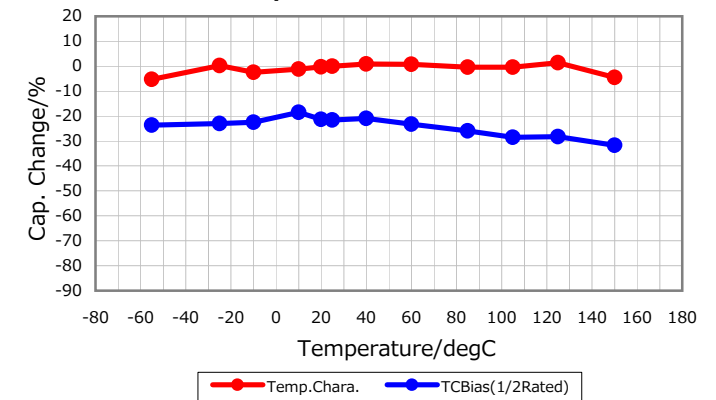
DC Bias Characteristic



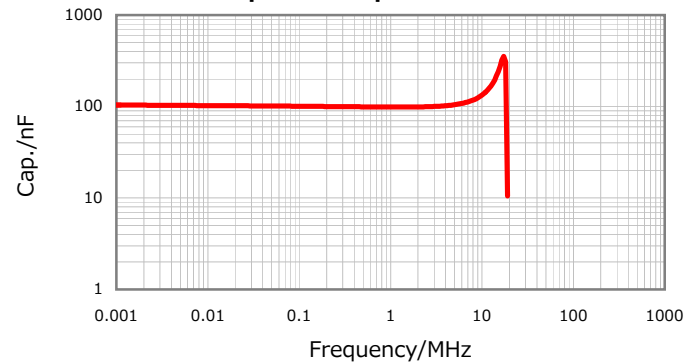
|Z|, ESR vs. Freq. Characteristics



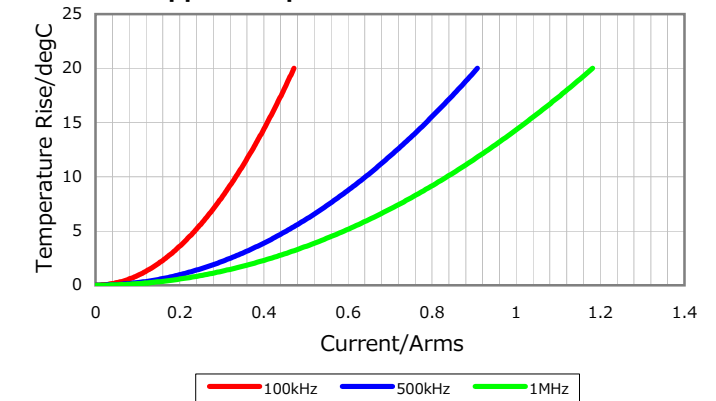
Temperature Characteristics



Cap. vs. Freq. Characteristic



Ripple Temperature Rise Characteristics



Characterization Sheet (Multilayer Ceramic Chip Capacitors)



⚠ All specifications are subject to change without notice.

January 3, 2016